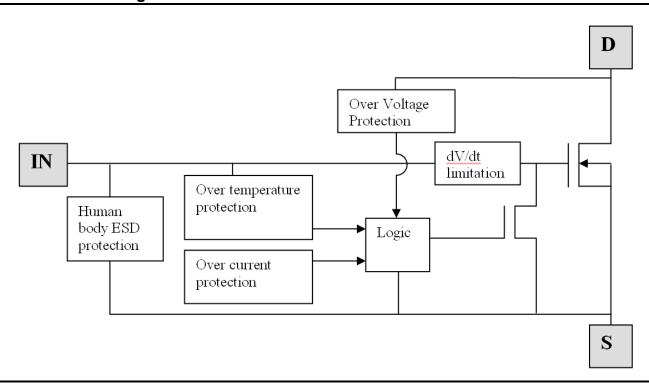


### **Functional Block Diagram**



#### Absolute Maximum Ratings (@T<sub>A</sub> = +25°C, unless otherwise stated.)

Characteristic	Symbol	Value	Units
Continuous Drain-Source Voltage	V <sub>DS</sub>	60	V
Drain-Source Voltage for Short Circuit Protection	V <sub>DS(SC)</sub>	36	V
Continuous Input Voltage	V <sub>IN</sub>	-0.5 to +6	V
Continuous Input Current @-0.2V $\leq$ V <sub>IN</sub> $\leq$ 6V Continuous Input Current @V <sub>IN</sub> $<$ -0.2V or V <sub>IN</sub> $>$ 6V	lin	No limit │ I <sub>IN</sub> │ ≤2	mA
Pulsed Drain Current @V <sub>IN</sub> = 3.3V	I <sub>DM</sub>	2	Α
Pulsed Drain Current @V <sub>IN</sub> = 5V	I <sub>DM</sub>	2.5	Α
Continuous Source Current (Body Diode) (Note 5)	I <sub>S</sub>	1	Α
Pulsed Source Current (Body Diode)	I <sub>SM</sub>	5	Α
Unclamped Single Pulse Inductive Energy, T <sub>J</sub> = +25°C, I <sub>D</sub> = 0.5A, V <sub>DD</sub> = 24V	E <sub>AS</sub>	120	mJ
Electrostatic Discharge (Human Body Model)	V нвм	4,000	V
Charged Device Model	V <sub>CDM</sub>	1,000	V

# Thermal Resistance ( $@T_A = +25^{\circ}C$ , unless otherwise specified.)

Characteristic	Symbol	Value	Units
Power Dissipation at $T_A = +25^{\circ}C$ (Note 5) Linear Derating Factor	P <sub>D</sub>	1.28 10	W mW/°C
Power Dissipation at T <sub>A</sub> = +25°C (Note 6) Linear Derating Factor	P <sub>D</sub>	1.65 12.4	W mW/°C
Thermal Resistance, Junction to Ambient (Note 5)	R <sub>0JA</sub>	98	°C/W
Thermal Resistance, Junction to Ambient (Note 6)	R <sub>0JA</sub>	76	°C/W
Thermal Resistance, Junction to Case (Note 7)	R <sub>θJC</sub>	12	°C/W
Operating Temperature Range	T <sub>J</sub> ,	-40 to +150	°C
Storage Temperature Range	T <sub>STG</sub>	-55 to +150	°C

 Device mounted on FR-4 substrate PC board, 2oz copper, with minimum recommended pad layout
 Device mounted on FR-4 substrate PC board, 2oz copper, with 1inch square copper plate. Notes:

<sup>7.</sup> Thermal resistance between junction and the mounting surfaces of drain and source pins.

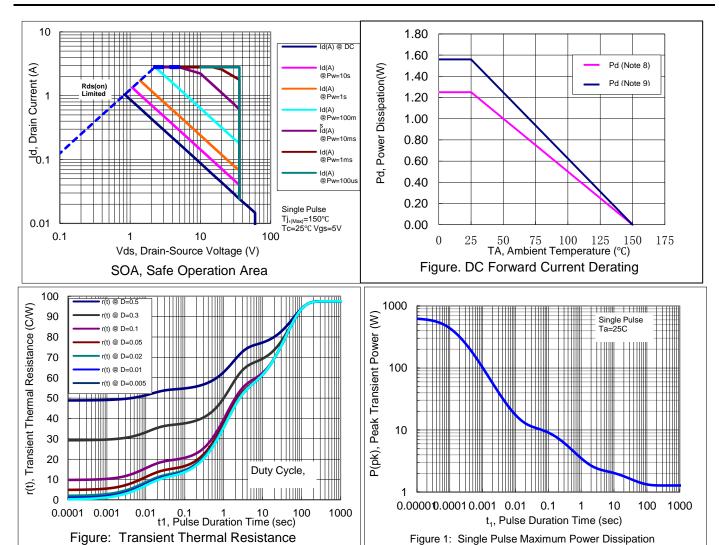


#### **Recommended Operating Conditions**

The ZXMS6004N8 s optimized for use with  $\mu$ C operating from 3.3V and 5V supplies.

Characteristic	Symbol	Min	Max	Unit
Input Voltage Range	V <sub>IN</sub>	0	5.5	V
Ambient Temperature Range	T <sub>A</sub>	-40	+125	°C
High Level Input Voltage for MOSFET to be on	V <sub>IH</sub>	3	5.5	V
Low Level Input Voltage for MOSFET to be off	V <sub>IL</sub>	0	0.7	V
Peripheral Supply Voltage (voltage to which load is referred)	V <sub>P</sub>	0	36	V

#### **Thermal Characteristics**



Note:

- 8. Device mounted on FR-4 substrate PC board, 2oz copper, with minimum recommended pad layout
- 9. Device mounted on FR-4 substrate PC board, 2oz copper, with 1inch square copper plate.



# **Electrical Characteristics** (@T<sub>A</sub> = +25°C, unless otherwise stated.)

Characteristic	Symbol	Min	Тур	Max	Unit	Test Condition
Static Characteristics						
Drain-Source Clamp Voltage	V <sub>DS(AZ)</sub>	60	65	70	V	$I_D = 10 \text{mA}$
Off State Drain Current	I <sub>DSS</sub>	-	_	0.5	μΑ	$V_{DS} = 12V, V_{IN} = 0V$
On State Drain Current		_	-	1		$V_{DS} = 36V, V_{IN} = 0V$
Input Threshold Voltage	V <sub>IN(th)</sub>	0.7	1	1.5	V	$V_{DS} = V_{GS}$ , $I_D = 1mA$
Input Current		-	60	100	μΑ	$V_{IN} = +3V$
Imput Current	I <sub>IN</sub>	_	120	200		$V_{IN} = +5V$
Input Current While Over-Temperature Active	_	ı	_	400	μA	$V_{IN} = +5V$
Static Drain-Source On-State Resistance	R <sub>DS(on)</sub>	ı	400	600	mΩ	$V_{IN} = +3V, I_D = 0.5A$
Static Drain-Source On-State Resistance		_	350	500	11177	$V_{IN} = +5V, I_D = 0.5A$
Continuous Drain Current (Note 5)	- I <sub>D</sub>	0.9	_	-		$V_{IN} = 3V$ ; $T_A = +25$ °C
		1.0	_	_	Α	$V_{IN} = 5V; T_A = +25^{\circ}C$
Continuous Drain Current (Note 6)		1.2	_	_		$V_{IN} = 3V; T_A = +25^{\circ}C$
Continuous Diain Current (Note 6)		1.3	_	-		$V_{IN} = 5V$ ; $T_A = +25$ °C
Current Limit (Note 10)	I <sub>D(LIM)</sub>	0.7	1.7	-	А	$V_{IN} = +3V$
Current Limit (Note 10)		1	2.2	-		$V_{IN} = +5V$
Dynamic Characteristics						
Turn On Delay Time	t <sub>d(on)</sub>	-	5	_		$V_{DD} = 12V, I_D = 0.5A, V_{GS} = 5V$
Rise Time	tr	-	10	_	μs	
Turn Off Delay Time	t <sub>d(off)</sub>	_	45	_		
Fall Time	t <sub>f</sub>	-	15	_		
Over-Temperature Protection						
Thermal Overload Trip Temperature (Note 11)	$T_{JT}$	150	+175	-	°C	_
Thermal Hysteresis (Note 11)	$\Delta T_{JT}$	ı	+10	-	°C	

Notes:

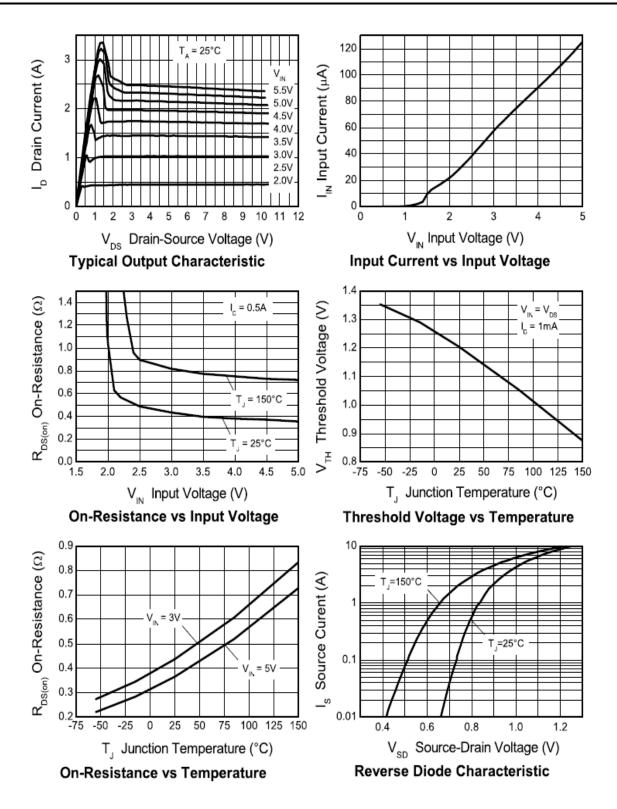
<sup>10.</sup> The drain current is restricted only when the device is in saturation (see graph 'typical output characteristic'). This allows the device to be used in the fully on state without interference from the current limit. The device is fully protected at all drain currents, as the low power dissipation generated outside saturation makes current limit unnecessary.

11. Over-temperature protection is designed to prevent device destruction under fault conditions. Fault conditions are considered as "outside" normal

operating range, so this part is not designed to withstand over-temperature for extended periods.

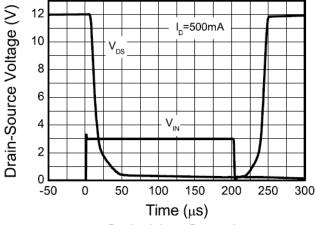


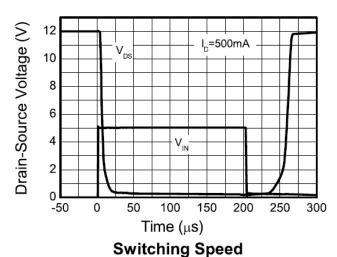
### **Typical Characteristics**



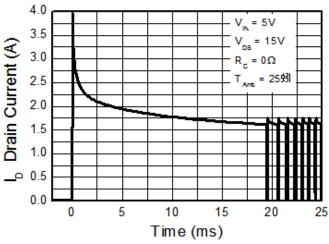


### Typical Characteristics (continued)





**Switching Speed** 

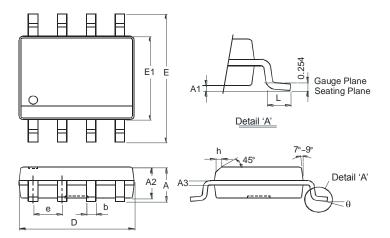


Typical Short Circuit Protection



#### **Package Outline Dimensions**

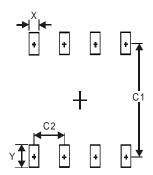
Please see AP02002 at http://www.diodes.com/datasheets/ap02002.pdf for the latest version.



SO-8				
Dim	Min	Max		
Α	-	1.75		
A1	0.10	0.20		
A2	1.30	1.50		
A3	0.15	0.25		
b	0.3	0.5		
D	4.85	4.95		
Е	5.90	6.10		
E1	3.85	3.95		
е	1.27 Typ			
h	-	0.35		
L	0.62	0.82		
θ	0°	8°		
All Dimensions in mm				

# **Suggested Pad Layout**

Please see AP02001 at http://www.diodes.com/datasheets/ap02001.pdf for the latest version.



Dimensions	Value (in mm)
X	0.60
Y	1.55
C1	5.4
C2	1.27



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